

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10711213	YANG ET AL.
	Examiner Sim, Yong	Art Unit 2635

SEARCHED

Class	Subclass	Date	Examiner
345	173	12/07/2006	Yong Sim
349	12	12/07/2006	Yong Sim

SEARCH NOTES

Search Notes	Date	Examiner
Consulted SPE Vu Le to clarify the claim language. Electrode layers disclosed in the prior art is construed as a detection circuit.	12/08/2006	Yong Sim
Conducted double patenting search on EAST and eDAN	12/08/2006	Yong Sim

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner